


<b>Search Notes</b>  	<b>Application/Control No.</b>  10595249	<b>Applicant(s)/Patent Under Reexamination</b>  MAKIURA ET AL.
	<b>Examiner</b>  RYAN D WALSH	<b>Art Unit</b>  2852

SEARCHED			
Class	Subclass	Date	Examiner
399	102	5/15/2008	RDW
399	123	5/15/2008	RDW
399	343	5/15/2008	RDW
399	350	5/15/2008	RDW
399	351	5/15/2008	RDW
399	398	5/16/2008	RDW
399	399	5/16/2008	RDW
	updated above	10/29/2008	RDW
	updated above	4/6/2009	RDW

SEARCH NOTES		
Search Notes	Date	Examiner
see East History	5/15/2008	RDW
see East History	5/16/2008	RDW
see East History	10/29/2008	RDW

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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